

FORM PTO 1449 (modified)

ATTY DOCKET NO.  
2006\_1135ASERIAL NO.  
NEWU.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
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Date Submitted to PTO: July 26, 2006

APPLICANT  
Takashi NISHIHARA et al.FILING DATE  
July 26, 2006

GROUP

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2004/0191686	9-30-04	Kitaura et al.			
	AB	2004/0115559	6-17-04	Kato et al.			
	AC	2004/0191683	9-30-04	Nishihara et al.			
	AD	2004/0202895	10-14-04	Inoue et al.			
	AE	2003/0190447	10-9-03	Kojima et al.			
	AF	2004/0047281	3-11-04	Nishihara et al.			
	AG	2004/0048029	3-11-04	Nishihara et al.			
	AH	6,153,063	11-28-00	Yamada et al.			
	AI	6,503,690	1-7-03	Uno et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ	2004-311011	11-4-04	Japan			corresponds to AA
	AK	2004-164850	6-10-04	Japan			abstract
	AL	2004-206851	7-22-04	Japan			corresponds to AB
	AM	2004-310992	11-4-04	Japan			corresponds to AC
	AN	03/044788	5-30-03	WO			corresponds to AD
	AO	11-339314	12-10-99	Japan			abstract
	AP	2003-341241	12-3-03	Japan			corresponds to AE
	AQ	2004-273040	9-30-04	Japan			abstract
	AR	2004-5767	1-8-04	Japan			abstract
	AS	10-275360	10-13-98	Japan			abstract

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AT	
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EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include cop. this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /E.M./

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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,821,707	11-23-04	Uno et al.			
	AB	6,456,584	9-24-02	Nagata et al.			
	AC	6,670,014	12-30-03	Nishihara et al.			
	AD	6,743,496	6-1-04	Nishihara et al.			
	AE	6,794,006	9-21-04	Nishihara et al.			
	AF	6,890,613	5-10-05	Nishihara et al.			
	AG	2005/0089799	4-28-05	Otoba et al.			
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AJ	0 825 595	2-25-98	Europe			x	
	AK	0 897 177	2-17-99	Europe			x	
	AL	2000-36130	2-2-00	Japan			abstract	
	AM	0 957 477	11-17-99	Europe			x	
	AN	2002-144736	5-22-02	Japan			abstract	
	AO	1 187 119	3-13-02	Europe			x	

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	

EXAMINER

/Elizabeth Mulvaney/

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